

**Notic of References Cited**

Application/Control No.

10/086,758

Applicant(s)/Patent Under  
Reexamination  
HENDRIKSEN ET AL.

Examiner

Christina Ildebrando

Art Unit

1725

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,665,325	09-1997	Verduijn, Johannes Petrus	423/709
	B	US-6,040,259	03-2000	Mohr et al.	502/67
	C	US-6,150,293	11-2000	Verduijn et al.	502/67
	D	US-6,350,428	02-2002	Verduijn et al.	423/702
	E	US-6,458,736	10-2002	Mohr et al.	502/67
	F	US-6,504,074	01-2003	Verduijn et al.	585/475
	G	US-6,111,157	08-2000	Hendriksen et al.	585/467
	H	US-2002/0183192	12-2002	Verduijn et al.	502/67
	I	US-4,977,120	12-1990	Sakurada et al.	502/64
	J	US-4,872,968	10-1989	Bowes, Emmerson	208/111.3
	K	US-6,051,051	04-2000	Hees et al.	95/96
	L	US-5,248,643	09-1993	Patil et al.	502/67
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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